# National Semiconductor

# TP5116A, TP5116A-1, TP5156A, TP5156A-1 Monolithic CODECs

# **General Description**

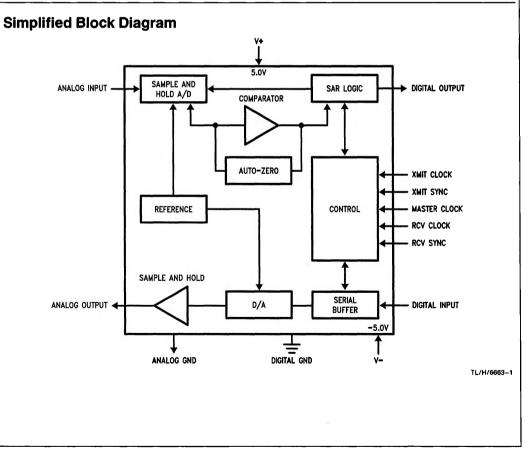
The TP5116A and TP5156A are monolithic PCM CODECs implemented with double-poly CMOS technology. The TP5116A is intended for  $\mu$ -law applications and the TP5156A is for A-law applications.

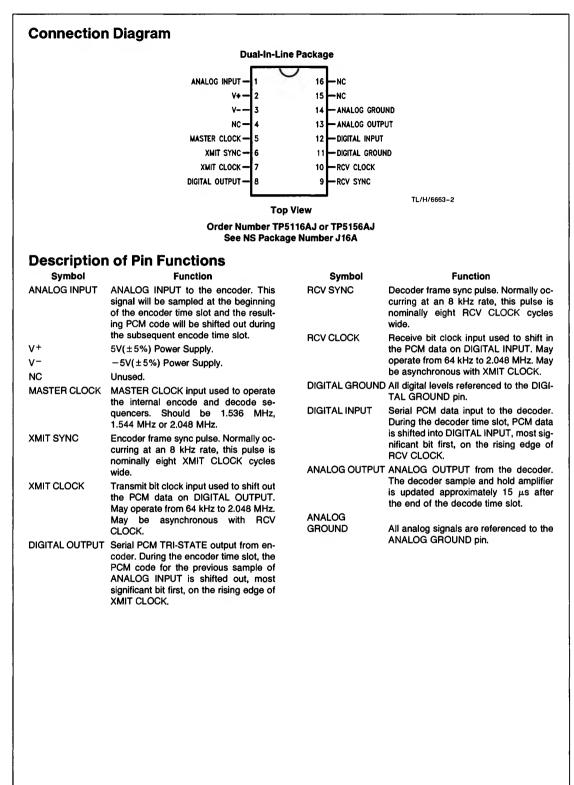
Each device contains separate D/A and A/D circuitry, all necessary sample and hold capacitors, and internal autozero circuits. Each device also contains a precision internal voltage reference, eliminating the need for an external reference. There are no internal connections to pins 15 or 16, making them directly interchangeable with CODECs using external reference components.

All devices are intended to be used with the TP3040 monolithic PCM filter which provides the input anti-aliasing function for the encoder, smooths the output of the decoder and corrects for the sin x/x distortion introduced by the decoder sample and hold output.

# Features

- TP5116A—µ-law coding (sign plus magnitude format)
- TP5156A—A-law coding
- Synchronous or asynchronous operation
- Precision voltage reference on-chip
- Internal sample-and-hold capacitors
- Internal auto-zero circuit
- Low operation power—40 mW typical
- ±5V operation
- TTL compatible digital interface





TP5116A/TP5116A-1/TP5156A/TP5156A-1

### **ENCODING FORMAT AT DIGITAL OUTPUT**

			Sig	TP51 n + M	16A agnitu	ıde			TP5156A A-Law (Includes Even Bit Inversion)							
V <sub>IN</sub> = + Full-Scale	1	1	1	1	1	1	1	.1	1	0	1	0	1	0	1	0
V <sub>IN</sub> = 0V	ſ1	0	0	0	0	0	0	0	1	1	0	1	0	1	0	1
	lo	0	0	0	0	0	0	0	0	1	0	1	0	1	0	1
V <sub>IN</sub> = -Full-Scale	0	1	1	1	1	1	1	1	0	0	1	0	1	0	1	0

# **Functional Description**

Approximately 4  $\mu$ s after the rising edge of the XMIT SYNC pulse, the voltage present on the ANALOG INPUT is sampled and the process of encoding that sample into a PCM code is begun. Simultaneously, the 8-bit PCM code corresponding to the previous sample is shifted out of the DIGI-TAL OUTPUT, MSB first, on the rising edge of the next eight cycles of the XMIT CLOCK. When XMIT SYNC (which is normally eight XMIT CLOCK cycles long) goes low, the TRI-STATE DIGITAL OUTPUT is returned to the high impedance state. On the TP5116A, the PCM code is in a  $\mu$ -law sign plus magnitude format. The TP5156A uses the standard A-law coding.

An 8-bit PCM code is shifted into DIGITAL INPUT on the rising edge of the first eight RCV CLOCK pulses after RCV SYNC goes high. RCV SYNC is nominally eight RCV CLOCK cycles wide. Approximately 15  $\mu$ s after RCV SYNC goes low, the ANALOG OUTPUT is updated to the voltage corresponding to the PCM input code.

All encoding and decoding operations are run from the MASTER CLOCK. MASTER CLOCK should be in the range of 1.536 MHz to 2.048 MHz and must be synchronous with XMIT CLOCK. The XMIT and RCV CLOCK may vary from 64 kHz to 2.048 MHz.

## **ENCODING DELAY**

The encoding process begins immediately at the beginning of the encode time slot and is concluded no later than 18 time slots later. In normal applications, the PCM data is not shifted out until the next time slot 125  $\mu$ s later, resulting in an encoding delay of 125  $\mu$ s. In some applications it is possible to operate the CODEC at a higher frame rate to reduce this delay. With a 2.048 MHz MASTER CLOCK, the FS rate could be increased to 15 kHz, reducing the delay from 125  $\mu$ s to 67  $\mu$ s.

### **DECODING DELAY**

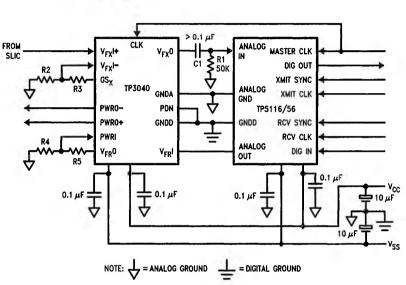
The decoding process begins immediately after the end of the decoder time slot. The output of the decoder sample and hold amplifier is updated 28 MASTER CLOCK cycles later. The decoding delay is therefore approximately 28 clock cycles plus one half of a frame time or, 81  $\mu$ s for a 1.544 MHz system with an 8 kHz frame rate or, 76  $\mu$ s for a 2.048 MHz system with an 8 kHz frame rate. Again, for some applications the frame rate could be increased to reduce this delay.

# **Typical Application**

A typical application of these CODECs used in conjunction with the TP3040 PCM filter is shown below. The values of resistor R1 and DC blocking capacitor C1, are non-critical. The capacitor value should exceed 0.1  $\mu$ F, R1 should be less than 50 kΩ, and the product R1×C1 should exceed 4 ms.

$$\begin{aligned} \text{XMIT GAIN} &= 20 \times \log \left( \frac{\text{R3} + \text{R2}}{\text{R2}} \right) + 3 \text{ dB} \\ \text{RCV GAIN} &= 20 \times \log \left( \frac{\text{R4}}{\text{R4} + \text{R5}} \right) \end{aligned}$$

The power supply decoupling capacitors should be 0.1  $\mu F.$  In order to take advantage of the excellent noise performance of these CODECs, care must be taken in board layout to prevent coupling of digital noise into the sensitive analog lines. For card insertion into a hot connector, care should be taken to insure that GNDA and GNDD are contacted prior to V<sub>CC</sub> and V<sub>BB</sub>.



TL/H/6663-5

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Operating Temperature	-25°C to +125°C
Storage Temperature	-65°C to +150°C
V+ with Respect to DIGITAL GROUND	7V
V <sup>-</sup> with Respect to DIGITAL GROUND	-7V

Voltage at Any Analog Input or Output	$V^ 0.3V$ to $V^+ + 0.3V$
Voltage at Any Digital Input or Output	GNDD $-0.3V$ to V <sup>+</sup> + 0.3V
Lead Temperature (Solderdip 10 sec.)	300°C
ESD rating to be determined.	

# **DC Electrical Characteristics**

Unless otherwise noted  $T_A = 0^{\circ}$ C to 70°C, V<sup>+</sup> = 5.0V ±5%, V<sup>-</sup> = -5.0V ±5%. Typical characteristics are specified at V<sup>+</sup> = 5.0V,V<sup>-</sup> = -5.0V and  $T_A = 25^{\circ}$ C. All digital signals are referenced to DIGITAL GROUND. All analog signals are referenced to ANALOG GROUND. Limits printed in bold characters are guaranteed for V<sup>+</sup> = 5.0V ±5%, V<sup>-</sup> = -5.0V ±5%; T<sub>A</sub> = 0°C to 70°C by correlation with 100% electrical testing at T<sub>A</sub> = 25°C. All other limits are assured by correlation with other production tests and/or product design and characterization.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
IGITAL INTER	RFACE	· · · · · · · · · · · · · · · · · · ·				
h	Input Current	0V <v<sub>IN<v+< td=""><td>- 10</td><td></td><td>10</td><td>μA</td></v+<></v<sub>	- 10		10	μA
VIL	Input Low Voltage		8		0.6	V
VIH	Input High Voltage		2.2			v
VOL	Output Low Voltage	I <sub>OL</sub> = 3.2 mA			0.4	V
VOH	Output High Voltage	I <sub>OH</sub> = 6 mA	2.4			V
NALOG INTE	RFACE	<u> </u>				
ZI	Analog Input Impedance when Sampling	Resistance in Series with Approximately 70 pF	2			kΩ
Z <sub>O</sub>	Output Impedance at Analog Output			10	20	Ω
IIN	Analog Input Bias Current	$V_{IN} = 0V$	-0.1		0.1	μA
R1 × C1	DC Blocking Time Constant		4.0			ms
C1	DC Blocking Capacitor		0.1			μF
R1	Input Bias Resistor				50	kΩ
OWER DISSIF	PATION					
ICC1	Operating Current, V <sub>CC</sub>			3.5	8.0	mA
I <sub>BB1</sub>	Operating Current, V <sub>BB</sub>			3.5	8.0	mA

# **AC Electrical Characteristics**

Unless otherwise noted,  $T_A = 25^{\circ}$ C, V<sup>+</sup> = 5.0V, V<sup>-</sup> = -5.0V. The analog input is a 0 dBm0, 1.02 kHz sine wave. The DIGITAL INPUT is a PCM bit stream generated by passing a 0 dBm0, 1.02 kHz sine wave through an ideal encoder. All output levels are sin x/x corrected, limits printed in bold characters are guaranteed for V<sup>+</sup> = 5.0V ±5%, V<sup>-</sup> = -5.0V ±5%; T<sub>A</sub> = 0°C to 70°C by correlation with 100% electrical testing at T<sub>A</sub> = 25°C. All other limits are assured by correlation with other production tests and/or product design and characterization.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
	Absolute Level	The nominal 0 dBm0 levels for the TP5116A is 1.227 Vrms and 1.231 Vrms for the TP5156A. The resulting nominal overload level is 2.5V peak for all devices. All gain measurements for the encode and decode portions of the devices are based on these nominal levels after the necessary sin x/x corrections are made.				
G <sub>RA</sub>	Receive Gain, Absolute	T <sub>A</sub> = 25°C, V <sup>+</sup> = 5V, V <sup>−</sup> = −5V TP5116A, TP5156A TP5116A-1, TP5156A-1	-0.125 -0.175		0.125 0.175	dB dB
GRAT	Absolute Receive Gain Variation with Temperature	$T_A = 0^\circ C$ to $70^\circ C$	-0.05		0.05	dB

# TP5116A/TP5116A-1/TP5156A/TP5156A-1

AC Electrical Characteristics (Continued) Unless otherwise noted,  $T_A = 25^{\circ}C$ , V<sup>+</sup> = 5.0V, V<sup>-</sup> = -5.0V. The analog input is a 0 dBm0, 1.02 kHz sine wave. The DIGITAL INPUT is a PCM bit stream generated by passing a 0 dBm0, 1.02 kHz sine wave through an ideal encoder. All output levels are sin x/x corrected. Limits printed in bold characters are guaranteed for V<sup>+</sup> = 5.0V  $\pm$  5%, V<sup>-</sup> = -5.0V  $\pm$  5%; T<sub>A</sub> = 0°C to 70°C by correlation with 100% electrical testing at T<sub>A</sub> = 25°C. All other limits are assured by correlation with other production tests and/or product design and characterization.

Symbol	Parameter	Conditions	Min	Тур	Max	Units
G <sub>RAV</sub>	Absolute Receive Gain Variation with Supply Voltage	$V^+ = 5V \pm 5\%, V^- = -5V \pm 5\%$	-0.07		0.07	dB
G <sub>XA</sub>	Transmit Gain, Absolute	T <sub>A</sub> = 25°C, V <sup>+</sup> = 5V, V <sup>-</sup> = -5V TP5116A, TP5156A TP5116A-1, TP5156A-1	-0.125 -0.175		0.125 0.175	dB
G <sub>XAT</sub>	Absolute Transmit Gain Variation with Temperature	$T_A = 0^{\circ}C$ to 70°C	-0.05		0.05	dB
G <sub>XAV</sub>	Absolute Transmit Gain Variation with Supply Voltage	$V^+ = 5V \pm 5\%, V^- = -5V \pm 5\%$	-0.07		0.07	dB
G <sub>RAL</sub>	Absolute Receive Gain Variation with Level	CCITT Method 2 Relative to - 10 dBm0 0 dBm0 to 3 dBm0 - 40 dBm0 to 0 dBm0 - 50 dBm0 to - 40 dBm0 - 55 dBm0 to - 50 dBm0	0.3 0.2 0.4 1.0		0.3 0.2 0.4 1.0	dB dB dB dB
G <sub>XAL</sub>	Absolute Transmit Gain Variation with Level	CCITT Method 2 Relative to - 10 dBm0 0 dBm0 to 3 dBm0 - 40 dBm0 to 0 dBm0 - 50 dBm0 to - 40 dBm0 TP5116A, TP5156A TP5116A-1, TP5156A-1 - 55 dBm0 to - 50 dBm0	-0.3 -0.2 -0.4 -0.475 -1.0		0.3 0.2 0.4 0.475 1.0	dB dB dB dB dB
STDR	Receive Signal to Distortion Ratio	Sinusoidal Test Method Input Level 30 dBm0 to 0 dBm0 40 dBm0 45 dBm0	35 29 25			dBC dBC dBC
STD <sub>X</sub>	Transmit Signal to Distortion Ratio	Sinusoidal Test Method Input Level - 30 dBm0 to 0 dBm0 - 40 dBm0 - 45 dBm0	35 29 25			dBC dBC dBC
NR	Receive Idle Channel Noise	D <sub>R</sub> = Idle Code			8	dBrnC0
N <sub>X</sub>	Transmit Idle Channel Noise	TP5116A, VF <sub>X</sub> = 0V TP5156A, VF <sub>x</sub> = 0V			13 ~66	dBrnC0 dBm0p
PPSRX	Positive Power Supply Rejection, Transmit	Input Level = 0V, $V_{CC}$ = 5.0 $V_{DC}$ + 300 mVrms, f = 1.02 kHz	50			dB
PPSR <sub>R</sub>	Positive Power Supply Rejection, Receive	$D_{R} = Idle Code$ $V_{CC} = 5.0 V_{DC} + 300 \text{ mVrms},$ f = 1.02  kHz	40			dB
NPSRX	Negative Power Supply Rejection, Transmit	Input Level = 0V, $V_{BB} = -5.0 V_{DC}$ + 300 mVrms, f = 1.02 kHz	50			dB
NPSRR	Negative Power Supply Rejection, Receive	$      D_{\rm R} = {\rm Steady  PCM  Code,} \\       V_{\rm BB} = -5.0  {\rm V}_{\rm DC} + 300  {\rm mVrms,} \\       f = 1.02  {\rm kHz} $	45			dB
CT <sub>XR</sub>	Transmit to Receive Crosstalk	D <sub>R</sub> = Steady PCM Code			-75	dB
CT <sub>RX</sub>	Receive to Transmit Crosswalk	Transmit Input Level = 0V TP5116A TP5156A			<b>70</b> <b>65</b> (Note 2)	dB dB

Note 1: Measured by extrapolation from the distortion test result at -50 dBm0 level.

Note 2: Theoretical worst-case for a perfectly zeroed encoder with alternating sign bit, due to the decoding law.

**Timing Specifications** Unless otherwise noted,  $T_A = 0^{\circ}C$  to 70°C,  $V^+ - +5V \pm 5^{\circ}$ ,  $V^- = -5V \pm 5^{\circ}$ . All digital signals are referenced to DIGITAL GROUND and are measured at  $V_{IH}$  and  $V_{IL}$  as indicated in the Timing Waveforms. Limits printed in bold characters are guaranteed for  $V^+ = 5.0V \pm 5^{\circ}$ ,  $V^- = -5.0V \pm 5^{\circ}$ ;  $T_A = 0^{\circ}C$  to 70°C by correlation with 100% electrical testing at  $T_A = 25^{\circ}C$ . All other limits are assured by correlation with other production tests and/or product design and characterization. All timing specifications measured at  $V_{OH} = 2.0V$  and  $V_{OL} = 0.7V$ .

Symbol	Parameter	Conditions	Min	Тур	Max	Units
FM	MASTER CLOCK Frequency		1.5	2.048	2.1	MHz
F <sub>X</sub> , F <sub>R</sub>	XMIT, RCV CLOCK Frequency		0.064	2.048	2.1	MHz
PWCLK	Clock Pulse Width	MASTER, XMIT, RCV CLOCKS	150			ns
tRC, tFC	Clock Rise and Fall Time	MASTER, XMIT, RCV CLOCKS			50	ns
t <sub>RS</sub> , t <sub>FS</sub>	Sync Pulse Rise and Fall Time	RCV, XMIT, SYNC			50	ns
tRCS, txCS	Clock to Sync Delay	RCV, XMIT	0			ns
txss	XMIT SYNC Set-Up Time		150			ns
txDD	XMIT Data Delay	Load = 100 pF + 2 LSTTL Loads			200	ns
t <sub>XDP</sub>	XMIT Data Present	Load = 100 pF + 2 LSTTL Loads			200	ns
txDT	XMIT Data TRI-STATE®				150	ns
tSRC	RCV CLOCK to RCV SYNC Delay		0			ns
t <sub>RDS</sub>	RCV Data Set-Up Time		0			ns
tRSS	RCV SYNC Set-Up Time		150			ns
<sup>t</sup> RDH	RCV Data Hold Time		100			ns
txsL	XMIT SYNC Low Time	64 kHz Operation	300			ns
t <sub>RSL</sub>	RCV SYNC Low Time	64 kHz Operation	17			(Note 3)

Note 3: RCV SYNC must remain low for at least 17 cycles of MASTER CLOCK, each frame.

# **Timing Waveforms**

